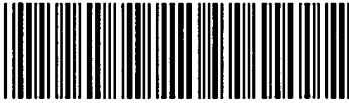


Search Notes

Application/Control No.

10/773,849

Examiner

Y Quach Lee

Applicant(s)/Patent under
Reexamination

TSURUTA ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	84 109 119 120 396	4/28/2005	YMY
250	462.1		
	465.1		
	466.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	4/18/2005	YMY